

Search Notes

Application/Control No.

10/578,082

Examiner

Hai H. Huynh

Applicant(s)/Patent under
Reexamination

OHTSUJI, TAKAMASA

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	336	6/25/2007	HHH
123	337	6/25/2007	HHH
123	73A	6/25/2007	HHH
123	73AD	6/25/2007	HHH
123	398	6/25/2007	HHH
123	400	6/25/2007	HHH
123	442	6/25/2007	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/25/2007	HHH